



Features

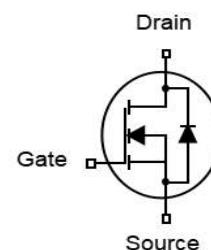
- N-Channel
- Fast Switching
- Low Gate Charge and R_{DSON}
- Low Reverse transfer capacitances
- 100% EAS Tested

V_{DS}	150	V
$R_{DS(on),TYP}$ @ $V_{GS}=10$ V	3.3	mΩ
$R_{DS(on),TYP}$ @ $V_{GS}=8$ V	3.5	mΩ
I_D	260	A

TO-247



Part ID	Package Type	Marking	Packing
ZTG033N15T	TO-247	ZTG033N15T	600pcs/Tape



Absolute Maximum Ratings $T_A=25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit	
Common Ratings (T_c=25°C Unless Otherwise Noted)				
V_{GS}	Gate-Source Voltage	±20	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	150	V	
T_J	Maximum Junction Temperature	150	°C	
T_{STG}	Storage Temperature Range	-55 to 150	°C	
I_{DM}	Drain Current-Continuous@ Current-Pulsed (Note 2)	$T_c=25^\circ\text{C}$	960	A
Mounted on Large Heat Sink				
I_D	(Note 1) Drain Current-Continuous	$T_c=25^\circ\text{C}$	260	A
		$T_c=100^\circ\text{C}$	151	A
P_D	Maximum Power Dissipation (Note 3)	500	W	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	0.25	°C/W	
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	50	°C/W	
Drain-Source Avalanche Ratings				
EAS	Avalanche Energy, Single Pulsed (Note 6)	1924	mJ	



Electrical Characteristics ($T_j=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated)						
V(BR)DSS	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	150	--	--	V
Idss	Zero Gate Voltage Drain Current	$V_{DS}=150\text{V}, V_{GS}=0\text{V}$	--	--	1	μA
IGSS	Gate-Body Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	--	--	± 100	nA
VGS(th)	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	--	4.0	V
RDS(on)	Drain-Source On-State Resistance	$V_{GS}=10\text{V}, I_D=100\text{A}$	--	3.3	3.8	$\text{m}\Omega$
RDS(on)	Drain-Source On-State Resistance	$V_{GS}=8\text{V}, I_D=50\text{A}$	--	3.5	4.0	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
Ciss	Input Capacitance	$V_{DS}=75\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	9940	--	pF
Coss	OutputCapacitance		--	1253	--	pF
Crss	ReverseTransferCapacitance		--	27	--	pF
Rg	GateResistancef=1MHz	f=1MHz	--	3.6	--	Ω
Qg	Total Gate Charge	$V_{DD}=75\text{V}, I_D=100\text{A}, V_{GS}= 10\text{V}$	--	147	--	nC
Qgs	Gate-SourceCharge		--	55	--	nC
Qgd	Gate-DrainCharge		--	31	--	nC
Switching Characteristics						
Td(on)	Turn-on Delay Time	$V_{DD}=75\text{V}, I_D = 100\text{A}, R_G=1.6\Omega, V_{GS}=10\text{V}$	--	35	--	ns
Tr	Turn-on Rise Time		--	86	--	ns
Td(off)	Turn-Off Delay Time		--	96	--	ns
Tf	Turn-Off Fall Time		--	44	--	ns
Source- Drain Diode Characteristics@ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
ISD	Source-Drain Current (Body Diode)		--	--	260	A
VSD	Forward on voltage	$I_S=100\text{A}, V_{GS}=0\text{V}$	--	--	1.4	V
Trr	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_S = 100\text{A}, V_R=75\text{V}, dI/dt=100\text{A}/\mu\text{s}$	--	143	--	ns
Qrr	Reverse Recovery Charge		--	620	--	nC

Notes:

- The rating only refers to the maximum absolute value of 25°C in the specification. If the shell temperature is higher than 25°C , it needs to be derated according to the actual environmental conditions.
- Pulse time 5us,pulse width is limited by the maximum junction temperature.
- The dissipated power value will change with the change of temperature, when greater than 25°C , the dissipated power value will decrease by $4.0 \text{ W}/^\circ\text{C}$ with the increase of 1°C of temperature.
- Pulse test: pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- Basically unaffected by operating temperature.
- EAS condition : $T_j=25^\circ\text{C}, V_{DD}=80\text{V}, L=1\text{mH}, R_g=25\Omega$

Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

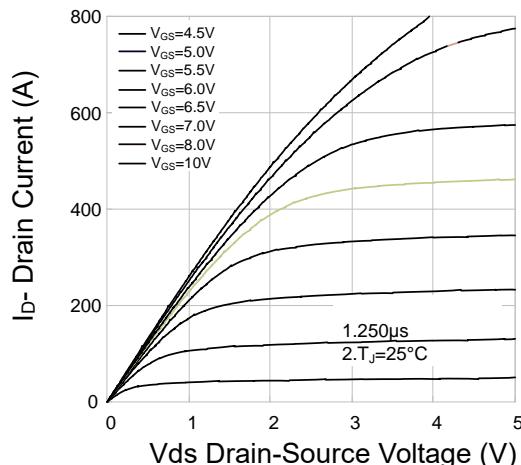


Figure 1 Output Characteristics

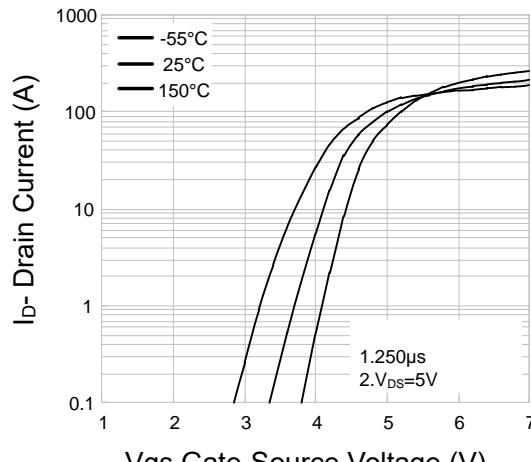


Figure 4 Transfer Characteristics

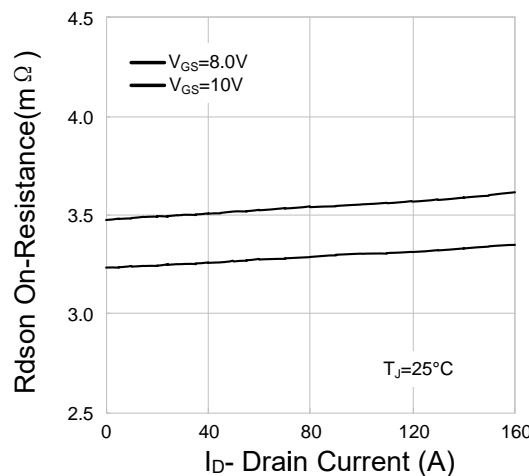


Figure 2 Rdson - Drain Current

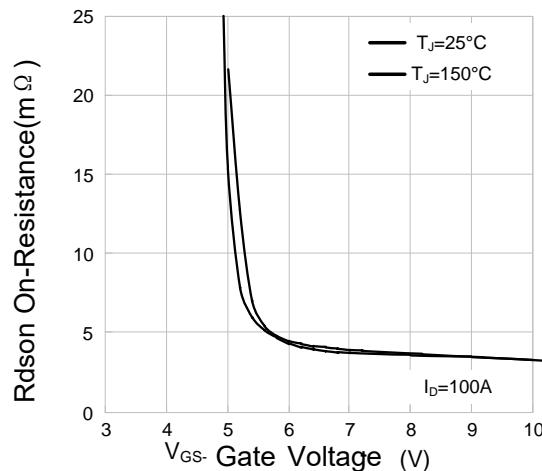


Figure 5 Rdson - Gate Voltage

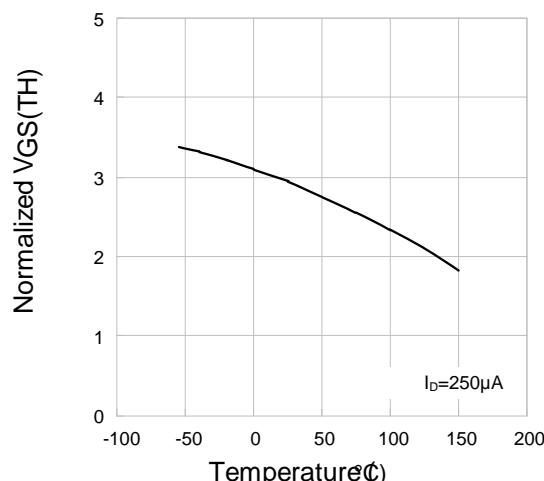


Figure 3 Threshold Voltage vs. Junction Temperature

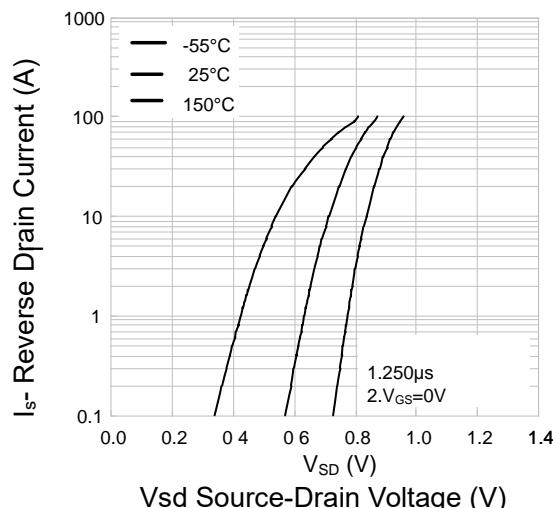


Figure 6 Source- Drain Diode Forward

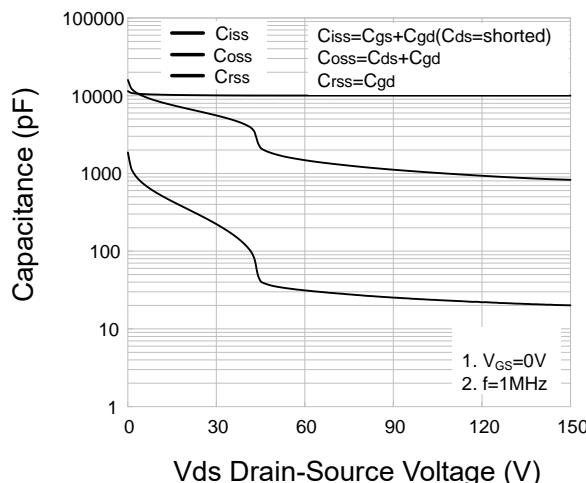


Figure 7 Capacitance vs Vds

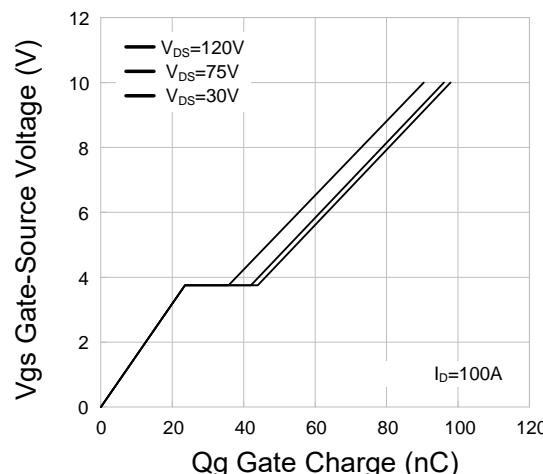


Figure 10 Gate Charge

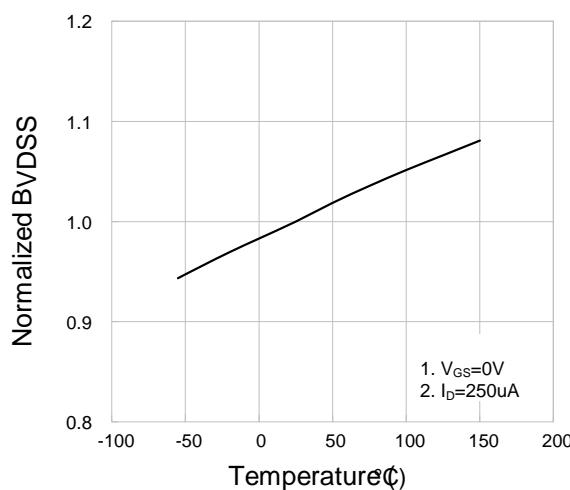


Figure 8 Breakdown Voltage vs. Junction Temperature

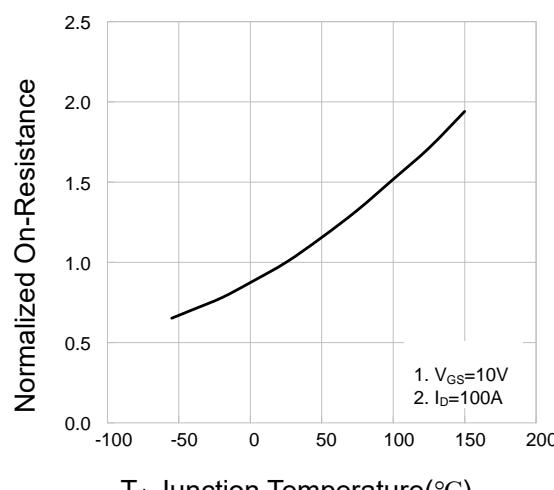


Figure 11 Rdson-Junction Temperature

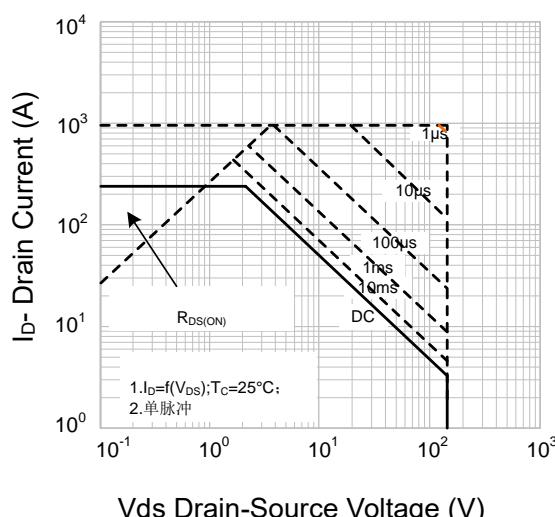


Figure 9 Safe Operation Area

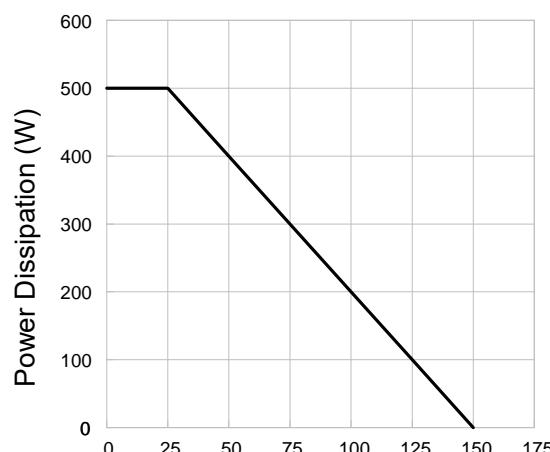


Figure 12 Power De-rating

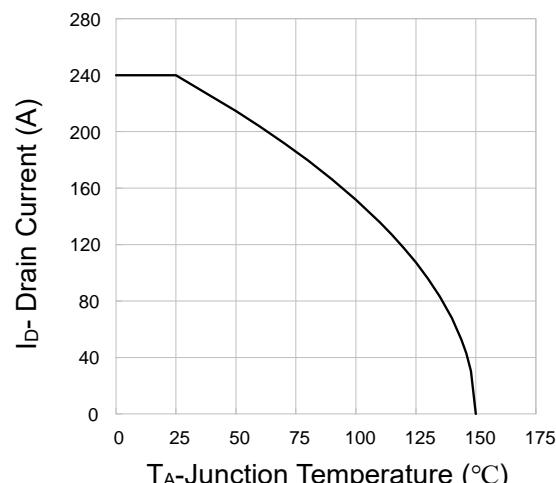


Figure 13 Current De-rating

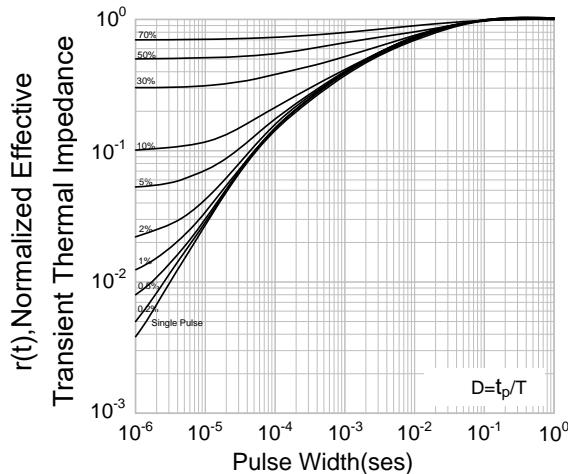
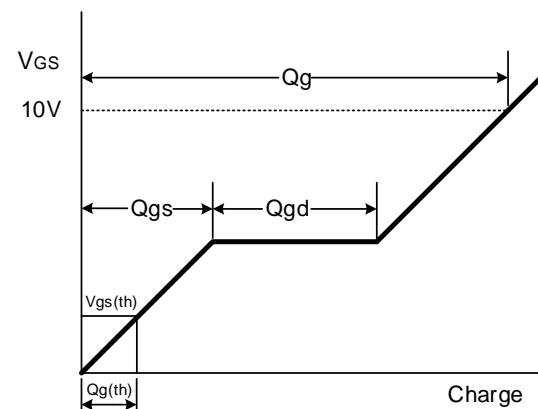
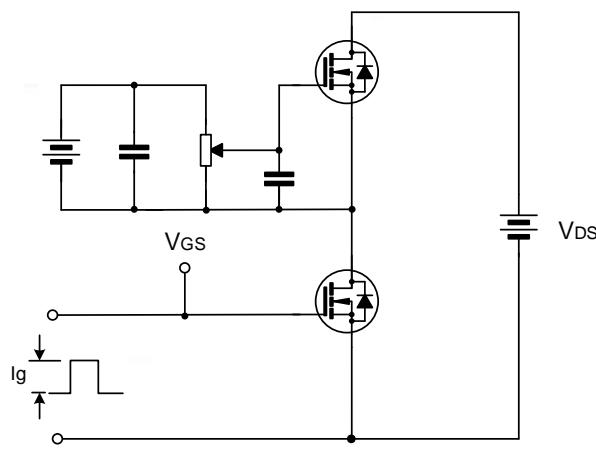


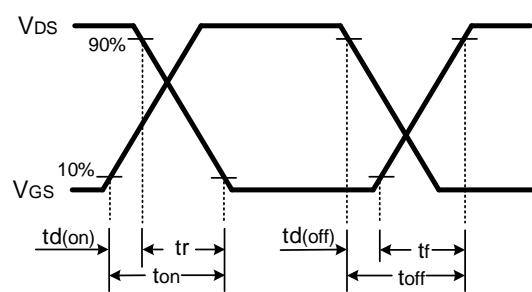
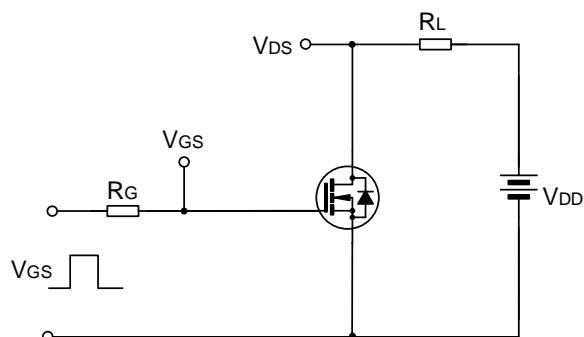
Figure 14 Normalized Maximum Transient Thermal Impedance



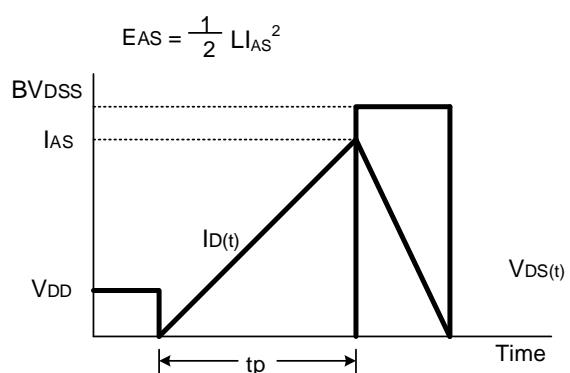
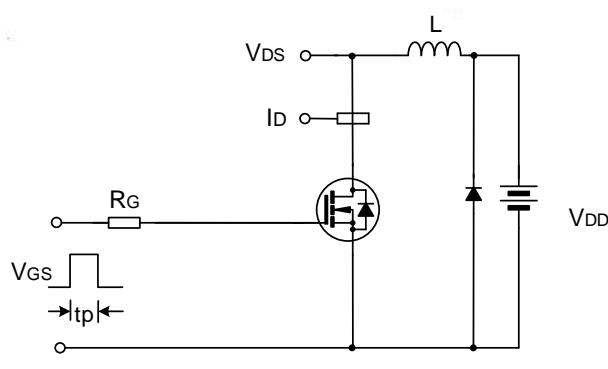
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

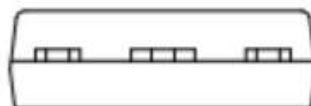
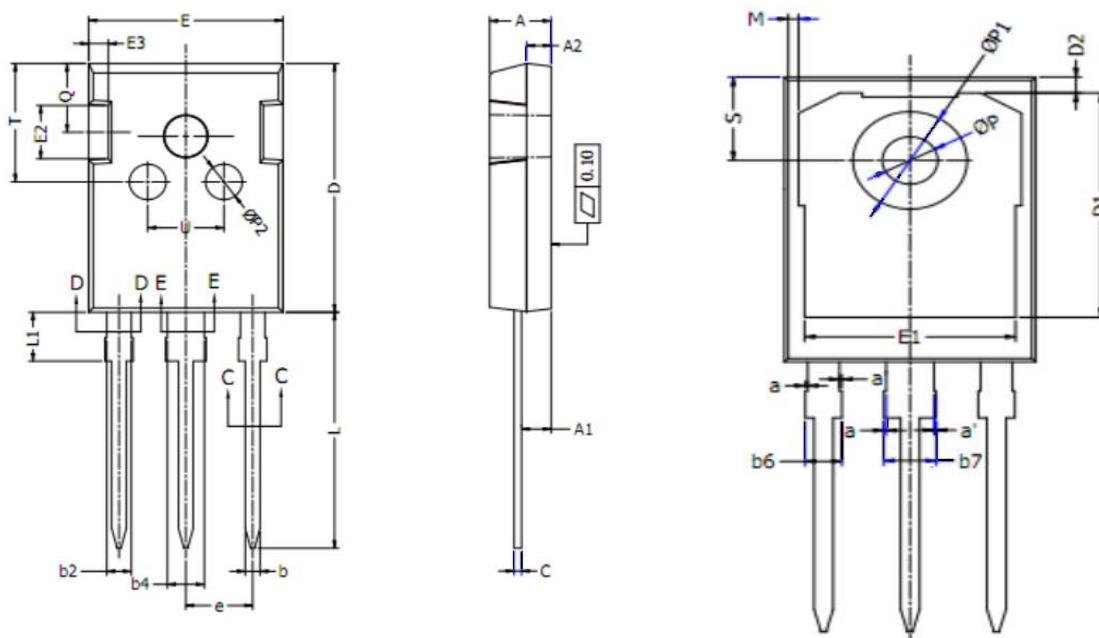


EAS Test Circuit & Waveforms





TO-247 Package Information



SYMBOL	MIN	NOM	MAX
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
a	0	---	0.15
a'	0	---	0.15
b	1.16	---	1.26
b1	1.15	1.2	1.22
b2	1.96	---	2.06
b3	1.95	2.00	2.02
b4	2.96	---	3.06
b5	2.96	3.00	3.02
b6	---	---	2.25
b7	---	---	3.25
c	0.59	---	0.66
c1	0.58	0.60	0.62
D	20.90	21.00	21.10
D1	16.25	16.55	16.85
D2	1.05	1.17	1.35
E	15.70	15.80	15.90
E1	13.10	13.30	13.50
E2	4.40	4.50	4.60
E3	1.50	1.60	1.70
e	5.436 BSC		
L	19.80	19.92	20.10
L1	---	---	4.30
M	0.35	---	0.95
P	3.40	3.50	3.60
P1	7.00	---	7.40
P2	2.40	2.50	2.60
Q	5.60	---	6.00
S	6.05	6.15	6.25
T	9.80	---	10.20
U	6.00	---	6.40

Customer Service

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